FAIRCHILD SEMICONDUCTOR IM

FDS3612 100V N-Channel PowerTrench[®] MOSFET

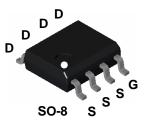
General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $R_{_{\text{DS(ON)}}}$ specifications. The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

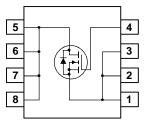
Applications

- DC/DC converter
- Motor Driver



Features

- 3.4 A, 100 V. $R_{DS(ON)} = 120 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$ $R_{DS(ON)} = 130 \text{ m}\Omega @ V_{GS} = 6 \text{ V}$
- Fast switching speed
- Low gate charge (14 nC typ)
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High power and current handling capability



Absolute Maximum Ratings T_A=25°C unless otherwise noted

| Symbol | Parameter | | | Ratings | Units |
|-----------------------------------|--|---|--------------|-------------|------------|
| V _{DSS} | Drain-Source Voltage | | | 100 | V |
| V _{GSS} | Gate-Source Voltage | | | ± 20 | |
| I _D | Drain Current – Continuous (Note 1 | | | 3.4 | А |
| | | – Pulsed | | 20 | |
| P _D | Power Dissipation for Single Operation | | (Note 1a) | 2.5 | W |
| | | | (Note 1b) | 1.2 | |
| | | | (Note 1c) | 1.0 | |
| T _J , T _{STG} | Operating an | d Storage Junction Tempe | rature Range | -55 to +175 | °C |
| Therma | I Characte | eristics | | | |
| R _{eJA} | Thermal Resi | Resistance, Junction-to-Ambient (Note 1a) | | 50 | °C/W |
| R _{eJC} | Thermal Resi | Resistance, Junction-to-Case (Note 1) | | 25 | °C/W |
| Packag | e Marking | and Ordering In | formation | | |
| Device Marking | | Device | Reel Size | Tape width | Quantity |
| FDS3612 | | FDS3612 | 13" | 12mm | 2500 units |

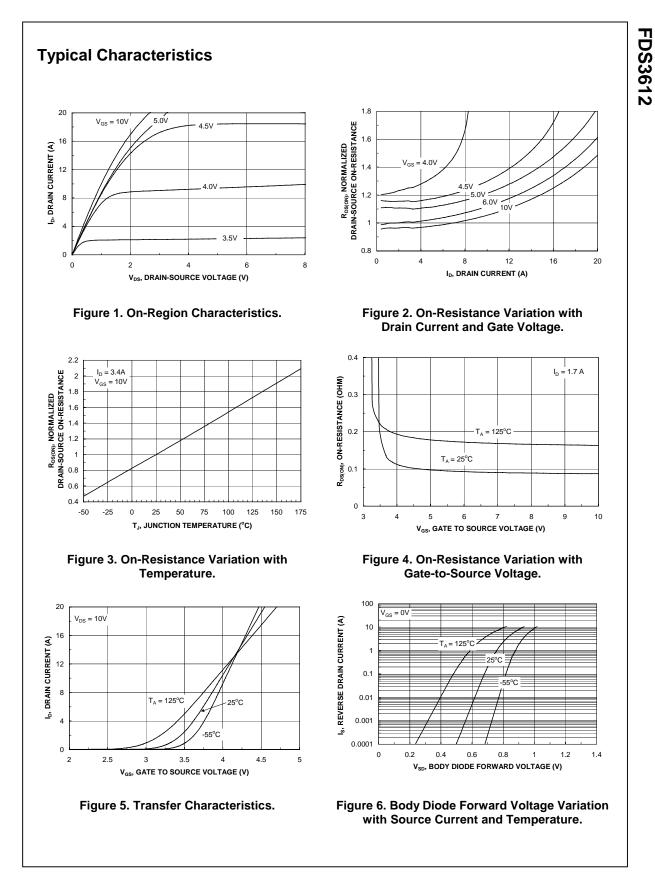
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FDS3612

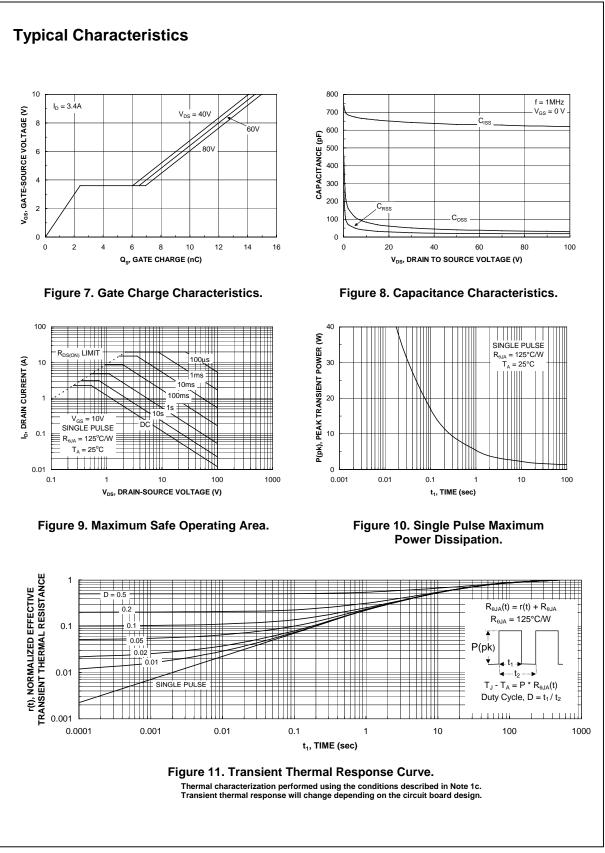
| rce Avalanche Ratings (Note Drain-Source Avalanche Energy Drain-Source Avalanche Current Cteristics Drain–Source Breakdown Voltage Breakdown Voltage Temperature Coefficient | Single Pulse, $V_{DD} = 50 \text{ V}$, $I_D = 3.4 \text{ A}$ $V_{GS} = 0 \text{ V}$, $I_D = 250 \mu\text{A}$ | 100 | | 90 3.4 | mJ A |
|---|--|---|--|--|--|
| Drain-Source Avalanche Energy Drain-Source Avalanche Current Cteristics Drain–Source Breakdown Voltage Breakdown Voltage Temperature | Single Pulse, $V_{DD} = 50 \text{ V}$, $I_D = 3.4 \text{ A}$ $V_{GS} = 0 \text{ V}$, $I_D = 250 \mu\text{A}$ | 100 | | | |
| cteristics Drain–Source Breakdown Voltage Breakdown Voltage Temperature | | 100 | | 3.4 | A |
| Drain–Source Breakdown Voltage Breakdown Voltage Temperature | | 100 | | | |
| Drain–Source Breakdown Voltage Breakdown Voltage Temperature | | 100 | | | |
| Breakdown Voltage Temperature | | | | | V |
| | $I_D = 250 \ \mu$ A, Referenced to 25° C | | 106 | | mV/°C |
| Zero Gate Voltage Drain Current | $V_{DS} = 80 V$, $V_{GS} = 0 V$ | | | 10 | μA |
| Gate-Body Leakage, Forward | $V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | 100 | nA |
| | | | | | nA |
| | | | | | |
| · · | | 2 | 2.5 | 1 | V |
| 5 | | 2 | 2.5 | 4 | - |
| Femperature Coefficient | $I_D = 250 \mu$ A, Referenced to 25 C | | -6 | | mV/°C |
| Static Drain–Source | $V_{GS} = 10 \text{ V}, \qquad I_D = 3.4 \text{ A}$ | | 88 | 120 | mΩ |
| Dn-Resistance | $V_{GS} = 6 \text{ V}, \qquad I_D = 3.2 \text{ A}$ | | 94 | 130 | |
| | | | 170 | 245 | |
| | | 10 | | | A |
| orward Transconductance | $V_{DS} = 10 \text{ V}, I_D = 3.4 \text{ A}$ | | 11 | | S |
| Characteristics | | | | | |
| nput Capacitance | $V_{DS} = 50 V$, $V_{GS} = 0 V$, | | 632 | | pF |
| Dutput Capacitance | f = 1.0 MHz | | 40 | | pF |
| Reverse Transfer Capacitance | | | 20 | | pF |
| Characteristics (Note 2) | | | | | |
| Furn–On Delay Time | $V_{DD} = 50 \text{ V}, \qquad I_D = 1 \text{ A},$ | | 8.5 | 17 | ns |
| Furn–On Rise Time | $V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$ | | 2 | 4 | ns |
| Furn-Off Delay Time | 1 | | 23 | 37 | ns |
| Furn-Off Fall Time | 1 | | 4.5 | 9 | ns |
| Fotal Gate Charge | $V_{DS} = 50 \text{ V}, I_{D} = 3.4 \text{ A},$ | | 14 | 20 | nC |
| Gate-Source Charge | $V_{GS} = 10 \text{ V}$ | | 2.4 | | nC |
| Gate-Drain Charge | | | 3.8 | | nC |
| urce Diode Characteristics | and Maximum Ratings | | | | |
| | | | | 2.1 | А |
| Aaximum Continuous Drain-Source | Diode Forward Current | | | | |
| Maximum Continuous Drain–Source Drain–Source Diode Forward | Diode Forward Current $V_{GS} = 0 \text{ V}, \qquad I_S = 2.1 \text{ A} \text{ (Note 2)}$ | | 0.75 | 1.2 | V |
| | Gate-Body Leakage, Reverse Cteristics (Note 2) Gate Threshold Voltage Generature Coefficient Static Drain–Source Dn–Resistance Dn–State Drain Current Forward Transconductance Characteristics Note 2) Furn–On Delay Capacitance Curn–On Delay Time Furn–Off Delay Time Furn–Off Fall Time Fordal Gate Charge Gate–Source Charge Gate–Drain Charge | Gate-Body Leakage, Reverse $V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$ Gate-Body Leakage, Reverse $V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$ Cteristics(Note 2)Gate Threshold Voltage $I_D = 250 \mu \text{A}, \text{Referenced to } 25^{\circ}\text{C}$ Gate Threshold Voltage $I_D = 250 \mu \text{A}, \text{Referenced to } 25^{\circ}\text{C}$ Gate Threshold Voltage $I_D = 250 \mu \text{A}, \text{Referenced to } 25^{\circ}\text{C}$ Gate Threshold Voltage $V_{GS} = 10 \text{ V}, I_D = 3.4 \text{ A}$ On-Resistance $V_{GS} = 10 \text{ V}, I_D = 3.4 \text{ A}$ On-Resistance $V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$ Forward Transconductance $V_{DS} = 10 \text{ V}, I_D = 3.4 \text{ A}$ Characteristics $V_{DS} = 10 \text{ V}, I_D = 3.4 \text{ A}$ Characteristics $V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$ Reverse Transfer Capacitance $V_{DS} = 50 \text{ V}, I_D = 1 \text{ A}, V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ Turn-On Delay Time $V_{DS} = 50 \text{ V}, I_D = 3.4 \text{ A}, V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ Turn-Off Delay Time $V_{DS} = 50 \text{ V}, I_D = 3.4 \text{ A}, V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ Turn-Off Fall Time $V_{DS} = 50 \text{ V}, I_D = 3.4 \text{ A}, V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ Gate-Drain Charge $V_{DS} = 50 \text{ V}, I_D = 3.4 \text{ A}, V_{GS} = 10 \text{ V}, V_{GS} = 10 \text$ | Gate-Body Leakage, Reverse $V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$ Cteristics(Note 2)Gate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250 \ \mu\text{A}$ 2Gate Threshold Voltage $I_D = 250 \ \mu\text{A}, \text{Referenced to } 25^{\circ}\text{C}$ 2Gate Threshold Voltage $I_D = 250 \ \mu\text{A}, \text{Referenced to } 25^{\circ}\text{C}$ 2Gate Threshold Voltage $V_{DS} = 10 \text{ V}, I_D = 3.4 \text{ A}$ 2Gate Threshold Voltage $V_{GS} = 10 \text{ V}, I_D = 3.4 \text{ A}$ 2Characteristics $V_{GS} = 10 \text{ V}, I_D = 3.4 \text{ A}$ 10Con-State Drain Current $V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$ 10Forward Transconductance $V_{DS} = 10 \text{ V}, I_D = 3.4 \text{ A}$ 10Characteristics $V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$ 10Characteristics (Note 2) $V_{DD} = 50 \text{ V}, I_D = 1 \text{ A}, V_{CS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ 10Turn-On Delay Time $V_{DS} = 50 \text{ V}, I_D = 3.4 \text{ A}, V_{CS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ 10Turn-Off Fall Time $V_{DS} = 50 \text{ V}, I_D = 3.4 \text{ A}, V_{CS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ Gate-Source Charge $V_{DS} = 50 \text{ V}, I_D = 3.4 \text{ A}, V_{CS} = 10 \text{ V}, R_{CEN} = 6 \Omega$ | Sate-Body Leakage, Reverse $V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$ Cteristics(Note 2)Sate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250 \ \mu\text{A}$ 22.5Sate Threshold Voltage $I_D = 250 \ \mu\text{A}, \text{ Referenced to } 25^{\circ}\text{C}$ -6Static Drain-Source $V_{GS} = 10 \text{ V}, I_D = 3.4 \text{ A}$ 88On-Resistance $V_{GS} = 6 \text{ V}, I_D = 3.2 \text{ A}$ 94VGS = 10 V, $I_D = 3.4 \text{ A}, T_J = 125^{\circ}\text{C}$ 170On-State Drain Current $V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$ 10Forward Transconductance $V_{DS} = 10 \text{ V}, I_D = 3.4 \text{ A}$ 11CharacteristicsV_DS = 10 V, $I_D = 3.4 \text{ A}$ 11Characteristics $V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, 632$ 40Reverse Transfer Capacitance $V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, 632$ 20Characteristics (Note 2) $V_{DD} = 50 \text{ V}, I_D = 1 \text{ A}, 20$ 23Turn-On Delay Time $V_{DS} = 50 \text{ V}, R_{GEN} = 6 \Omega$ 23Turn-Off Delay Time $V_{DS} = 50 \text{ V}, I_D = 3.4 \text{ A}, 14$ 44Sate-Source Charge $V_{DS} = 50 \text{ V}, I_D = 3.4 \text{ A}, 14$ Sate-Drain Charge $V_{DS} = 50 \text{ V}, I_D = 3.4 \text{ A}, 23$ | Bate-Body Leakage, Reverse $V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$ -100 Cteristics (Note 2) -100 Bate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$ 2 2.5 4 Bate Threshold Voltage $I_D = 250 \mu\text{A}, \text{Referenced to } 25^{\circ}\text{C}$ -6 -6 Bate Threshold Voltage $I_D = 250 \mu\text{A}, \text{Referenced to } 25^{\circ}\text{C}$ -6 -6 Static Drain-Source $V_{GS} = 10 \text{ V}, I_D = 3.4 \text{ A}$ 88 120 On-Resistance $V_{GS} = 10 \text{ V}, I_D = 3.4 \text{ A}, T_J = 125^{\circ}\text{C}$ 170 245 On-State Drain Current $V_{GS} = 10 \text{ V}, I_D = 3.4 \text{ A}$ 11 Characteristics On-State Drain Current $V_{GS} = 10 \text{ V}, I_D = 3.4 \text{ A}$ 11 Characteristics On-State Drain Current $V_{GS} = 10 \text{ V}, I_D = 3.4 \text{ A}$ 11 Characteristics Output Capacitance $V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, I_D = 3.4 \text{ A}$ 11 Characteristics 632 C Characteristics (Note 2) Set = 10 \text{ V}, R_{GEN} = 6 \Omega 2 4 2 4 V_{OD} = 50 \text |

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

FDS3612 Rev B1(W)



FDS3612 Rev B1(W)



FDS3612

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